

**Problem 1.**

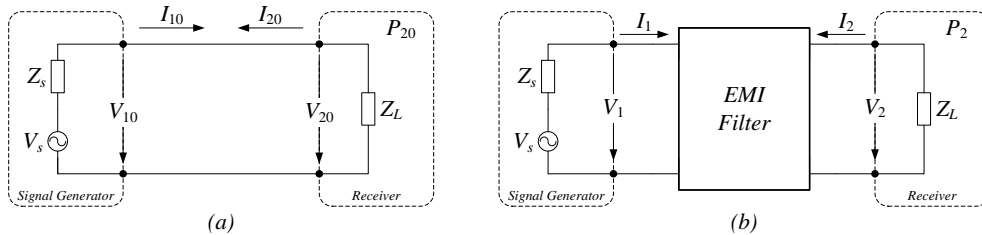
You measure the *Insertion Loss* (IL) of a filter with a signal generator with  $50 \Omega$  output impedance and a spectrum analyzer with  $1 \text{ M}\Omega$  input impedance. You have used this setup without impedance matching network and you realize this fact a few days later. What can you do in order to correct the results?

**Problem 2.**

Consider the setup for measuring insertion loss  $IL = 10 \cdot \lg\left(\frac{P_{20}}{P_2}\right)$  as shown in figure below. The test item

is a noise suppression capacitor with reactance  $X$ . The impedances of the signal generator and measuring equipment are resistive and equal to  $50 \Omega$ . Calculate and draw the insertion loss as a function of frequency in the following cases:

- a)  $X$  is an ideal capacitor  $C = 10 \mu\text{F}$ .
- b)  $X$  is an ideal inductor  $L = 1 \mu\text{H}$ .
- c)  $X$  is a real capacitor with  $C = 10 \mu\text{F}$  and series inductance  $L = 1 \mu\text{H}$ .



**Problem 3**

A single-stage  $LC$ -filter, shown in the figure below, is used to suppress *common mode* (CM) noise from a power supply. Filter component values are:  $C_x = 47 \text{ nF}$ ,  $C_y = 2.2 \text{ nF}$  and  $L = 0.13 \text{ mH}$ . Calculate the CM  $IL$  of the filter at  $150 \text{ kHz}$  and  $1 \text{ MHz}$ . Assume three different measurement resistances:  $50 / 50 \Omega$ ,  $0.1 / 100 \Omega$ , and  $100 / 0.1 \Omega$ .

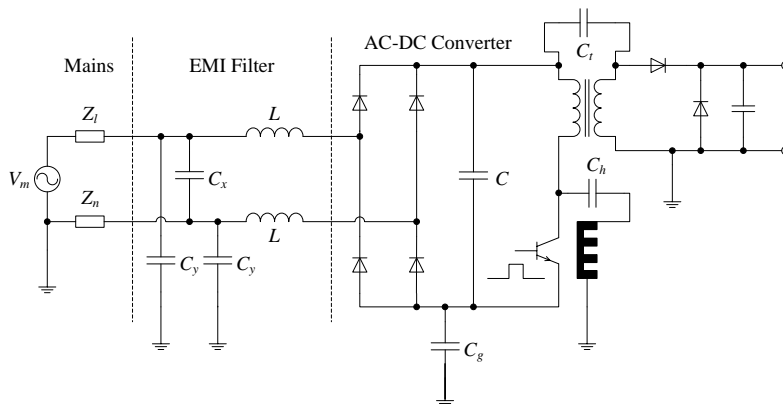


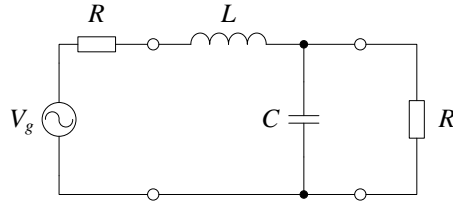
Fig. 1. A switch-mode power supply (SMPS) with input EMI filter.

#### Problem 4

This continues the previous problem: For the SMPS in Problem 3, draw the *differential mode* (DM) noise equivalent circuit of the filter and calculate the value of *DM insertion loss* ( $IL_{DM}$ ) of that filter at 150 kHz and 1 MHz. Use the same values as in Problem 3 and compare the results with the previous ones for CM noise.

#### Problem 5

Design an LC-filter, which provides insertion loss of 50 dB at 150 kHz. The allowed 50 Hz voltage drop is 5 V when the current is 15 A and  $R = 5 \Omega$ . Sketch the diagram of insertion loss versus frequency.



#### Problem 6

This problem highlights the case of mismatch due to low source impedance. Consider a single stage LC-filter (1 mH / 250 nF). The source impedance  $Z_g$  is assumed to be zero. The worst case  $IL$  is achieved when load impedance  $Z_L$  is purely inductive ( $R_L = 0$ ,  $L_L \neq 0$ ). What is the value of the load inductance  $L_L$  to have the worst case at 150 kHz? What is the value of  $IL$  at 150 kHz, if a  $50 \Omega$  resistive load is assumed?

## SOLUTIONS

### Solution 1:

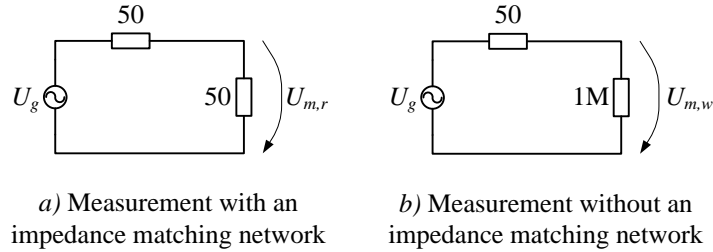


Fig. 2. Equivalent circuits for the measurements.

From Fig. 2a) the voltage measured by the instrument should be:

$$\frac{U_{m,r}}{U_g} = \frac{50}{50+50} \Rightarrow U_{m,r} = \frac{U_g}{2} \quad (1.1)$$

Instead, due to the wrong set up, the measured voltage is:

$$\frac{U_{m,w}}{U_g} = \frac{10^6}{10^6+50} \Rightarrow U_{m,w} \approx U_g \quad (1.2)$$

Therefore, the wrongly measured result should be divided by two to get the right one, which would have been obtained with an impedance matching network.

### Solution 2:

If  $Z_s = Z_L = R$  the insertion loss is given by equation (4.47) in the handout:

$$IL = 20 \cdot \lg \left( \frac{V_s}{2V_2} \right) \quad (1.3)$$

When the test item is inserted, the circuit looks like this:

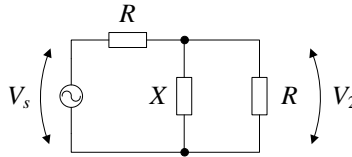


Fig. 3. Equivalent circuit for  $IL$  measurements of suppression capacitors.

And the voltage ratio in (1.3) is:

$$\frac{V_2}{V_s} = \frac{\frac{XR}{X+R}}{R + \frac{XR}{X+R}} = \frac{XR}{R^2 + 2XR} \Leftrightarrow \frac{U_o}{2U_m} = \frac{R+2X}{2X} = 1 + \frac{R}{2X} \quad (1.4)$$

a)  $X$  is an ideal capacitor  $C = 10 \mu\text{F}$

Substitute equation for capacitor's impedance in (1.4):

$$X = \frac{1}{j\omega C} \Rightarrow \frac{V_s}{2V_2} = 1 + j \frac{\omega CR}{2} \quad (1.5)$$

After inserting (1.5) in (1.3) the insertion loss is:

$$IL = 20 \cdot \lg \left| \frac{V_s}{2V_2} \right| = 20 \cdot \lg \left| 1 + j \frac{\omega CR}{2} \right| = 20 \cdot \lg \left[ 1 + \left( \frac{\omega CR}{2} \right)^2 \right]^{\frac{1}{2}} = 10 \cdot \lg \left[ 1 + \left( \frac{\omega CR}{2} \right)^2 \right] \quad (1.6)$$

b)  $X$  is an ideal inductor  $L = 1 \mu\text{H}$

Substitute equation for inductor's impedance in (1.4):

$$X = j\omega L \Rightarrow \frac{V_s}{2V_2} = 1 + \frac{R}{2j\omega L} = 1 - j \frac{R}{2\omega L} \quad (1.7)$$

Then the insertion loss is:

$$IL = 20 \cdot \lg \left| \frac{V_s}{2V_2} \right| = 20 \cdot \lg \left| 1 - j \frac{R}{2\omega L} \right| = 20 \cdot \lg \left[ 1 + \left( \frac{R}{2\omega L} \right)^2 \right]^{\frac{1}{2}} = 10 \cdot \lg \left[ 1 + \left( \frac{R}{2\omega L} \right)^2 \right] \quad (1.8)$$

c) Finally, for a more realistic capacitor, i.e. with its series inductance, from (1.4) it follows:

$$X = j\omega L + \frac{1}{j\omega C} = \frac{1 - \omega^2 LC}{j\omega C} \Rightarrow \frac{V_s}{2V_2} = 1 + j \frac{\omega CR}{2(1 - \omega^2 LC)} \quad (1.9)$$

Then the insertion loss is:

$$IL = 20 \cdot \lg \left| \frac{V_s}{2V_2} \right| = 20 \cdot \lg \left| 1 + j \frac{\omega CR}{2(1 - \omega^2 LC)} \right| = 10 \cdot \lg \left[ 1 + \left( \frac{\omega CR}{2(1 - \omega^2 LC)} \right)^2 \right] \quad (1.10)$$

The  $IL$  for the three cases considered above is plotted in Fig. 4. Note that the parasitic series inductance reduces the effectiveness of the noise suppression capacitor above resonant frequency.

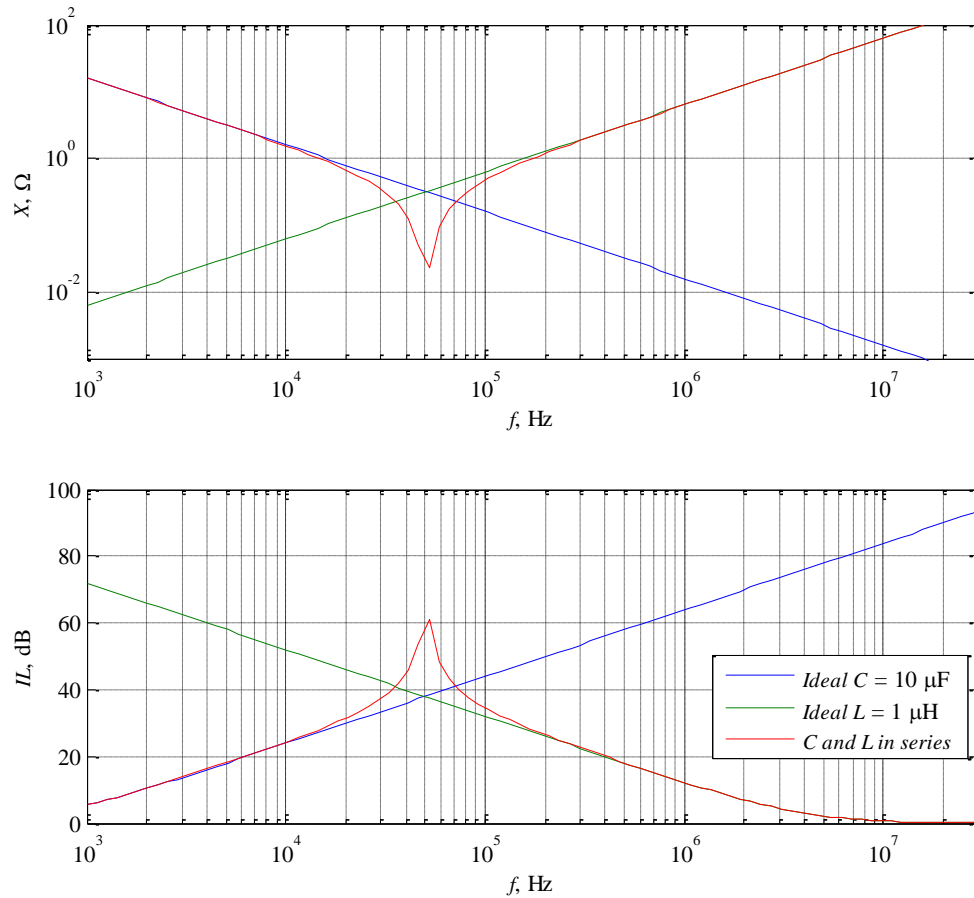


Fig. 4. Impedance and Insertion Loss plots illustrating Problem 2.

**Solution 3:**

Fig. 5a) shows the CM equivalent circuit of the filter in Problem 3.

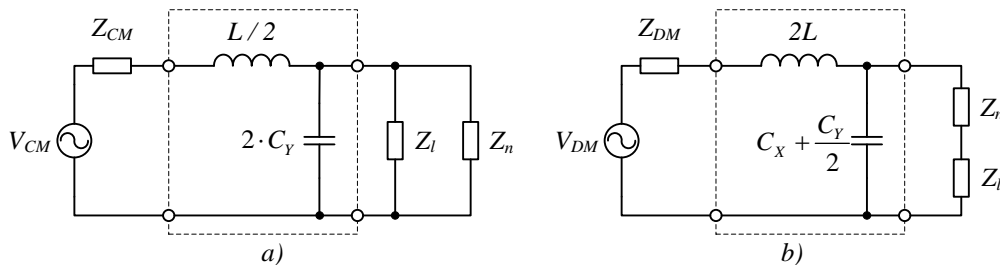


Fig. 5. Equivalent circuits of the filter in Problem 3 a) for CM, b) for DM noise.

The CM insertion loss ( $IL_{CM}$ ) is measured using the test method shown in Fig. 7a). Because there are three different combinations of source and load impedances ( $Z_g$  and  $Z_m$  respectively) it is better to obtain a general expression for the  $IL_{CM}$  of an LC-cell as a function of  $Z_g$  and  $Z_m$ . From Fig. 6 the ratio between the measured voltage  $V_m$  and that of the signal generator  $V_g$  is:

$$\frac{V_m}{V_g} = \frac{V_2}{V_g} = \frac{Z_m \parallel X_{C_e}}{Z_m \parallel X_{C_e} + X_m + Z_g} = \frac{Z_m}{Z_m + Z_g - \omega^2 C_e L_e Z_m + j\omega(L_e + C_e Z_m Z_g)} \quad (1.11)$$

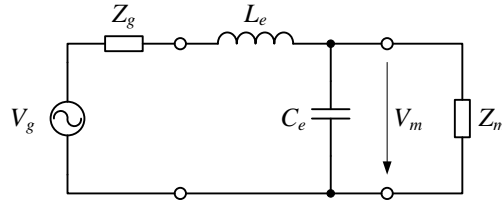


Fig. 6. Equivalent circuit when measuring the  $IL$  from a single  $LC$ -cell.

The same ratio without filter is:

$$\frac{V_m}{V_g} = \frac{V_1}{V_g} = \frac{Z_m}{Z_m + Z_g} \quad (1.12)$$

From (1.11) and (1.12) the ratio of  $V_1$  and  $V_2$  can be found. Insert it in (1.3) to get the  $IL$ :

$$IL = 20 \cdot \lg \left| \frac{V_1}{V_2} \right| = 10 \cdot \lg \left[ \left( 1 - \frac{\omega^2 L_e C_e Z_m}{Z_m + Z_g} \right)^2 + \left( \frac{\omega(L_e + C_e Z_m Z_g)}{Z_m + Z_g} \right)^2 \right] \quad (1.13)$$

For CM,  $L_e = \frac{L}{2} = 0.065 \text{ mH}$ ,  $C_e = 2 \cdot C_Y = 4.4 \text{ nF}$ , and  $IL_{CM}$  for 150 kHz and 1 MHz is:

$$\begin{array}{lll} IL_{CM} \left| \begin{array}{l} 150 \text{ kHz} \\ 50\Omega/50\Omega \end{array} \right. = 1.05 \text{ dB} & IL_{CM} \left| \begin{array}{l} 150 \text{ kHz} \\ 0.1\Omega/100\Omega \end{array} \right. = 1.38 \text{ dB} & IL_{CM} \left| \begin{array}{l} 150 \text{ kHz} \\ 100\Omega/0.1\Omega \end{array} \right. = -0.31 \text{ dB} \\ IL_{CM} \left| \begin{array}{l} 1 \text{ MHz} \\ 50\Omega/50\Omega \end{array} \right. = 16.47 \text{ dB} & IL_{CM} \left| \begin{array}{l} 1 \text{ MHz} \\ 0.1\Omega/100\Omega \end{array} \right. = 12.46 \text{ dB} & IL_{CM} \left| \begin{array}{l} 1 \text{ MHz} \\ 100\Omega/0.1\Omega \end{array} \right. = 20.9 \text{ dB} \end{array} \quad (1.14)$$

Note that in compliance tests, thanks to the LISN, the load impedance is  $Z_m = 25 \Omega$  (two  $50 \Omega$  resistors in parallel). However, the CM noise source impedance  $Z_{CM}$  (in Fig. 5a) is unknown and different from the standard source resistances used ( $0.1 \Omega$ ,  $50 \Omega$ , or  $100 \Omega$ ). Therefore, the performance of this filter in compliance tests will differ, from the  $IL$  shown by filter manufacturers.

Moreover, in real life operation the load impedance (a combination of  $Z_l$  and  $Z_n$ ), is also different from the LISN's resistors. Therefore, the real life noise reduction is different from both – the filter manufacturer's  $IL$  curves, and the  $IL$  demonstrated in compliance testing.

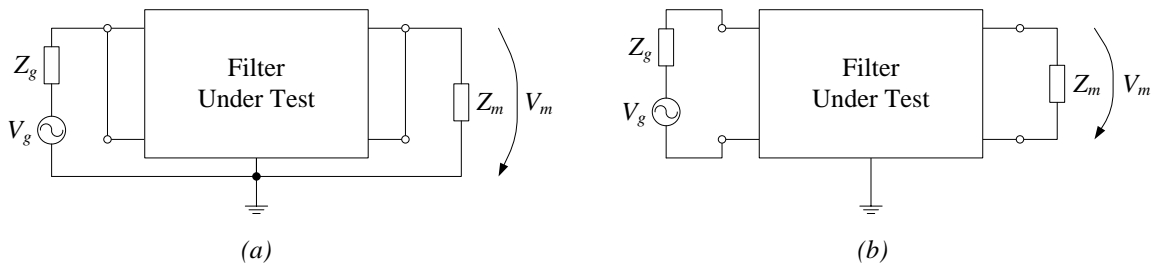


Fig. 7. Measurement set up for: a) CM  $IL$ ; b) DM  $IL$ .

#### Solution 4:

The equivalent circuit for DM was shown in Fig. 5b). It is similar to that of CM, found in the previous problem, but  $L_e$  and  $C_e$  are different:

$$L_e = 2 \cdot L = 260 \mu\text{H} \quad C_e = C_X + \frac{C_Y}{2} = 48.1 \text{ nF} \quad (1.15)$$

Although the measurement set up for DM, shown in Fig. 7b), is different from that for CM, the equivalent circuit of the filter is again an LC-cell, as it was for CM (Fig. 6). Then the DM *IL* for the frequencies in question can be calculated when the values from (1.15) are used in (1.13):

$$\begin{array}{lll} IL_{DM} \left. \begin{array}{l} 150 \text{ kHz} \\ 50\Omega/50\Omega \end{array} \right\} = 15.26 \text{ dB} & IL_{DM} \left. \begin{array}{l} 150 \text{ kHz} \\ 0.1\Omega/100\Omega \end{array} \right\} = 8.44 \text{ dB} & IL_{DM} \left. \begin{array}{l} 150 \text{ kHz} \\ 100\Omega/0.1\Omega \end{array} \right\} = 20.33 \text{ dB} \\ IL_{DM} \left. \begin{array}{l} 1 \text{ MHz} \\ 50\Omega/50\Omega \end{array} \right\} = 47.85 \text{ dB} & IL_{DM} \left. \begin{array}{l} 1 \text{ MHz} \\ 0.1\Omega/100\Omega \end{array} \right\} = 24.27 \text{ dB} & IL_{DM} \left. \begin{array}{l} 1 \text{ MHz} \\ 100\Omega/0.1\Omega \end{array} \right\} = 53.85 \text{ dB} \end{array} \quad (1.16)$$

The *IL* characteristics for both CM and DM are plotted in Fig. 8.

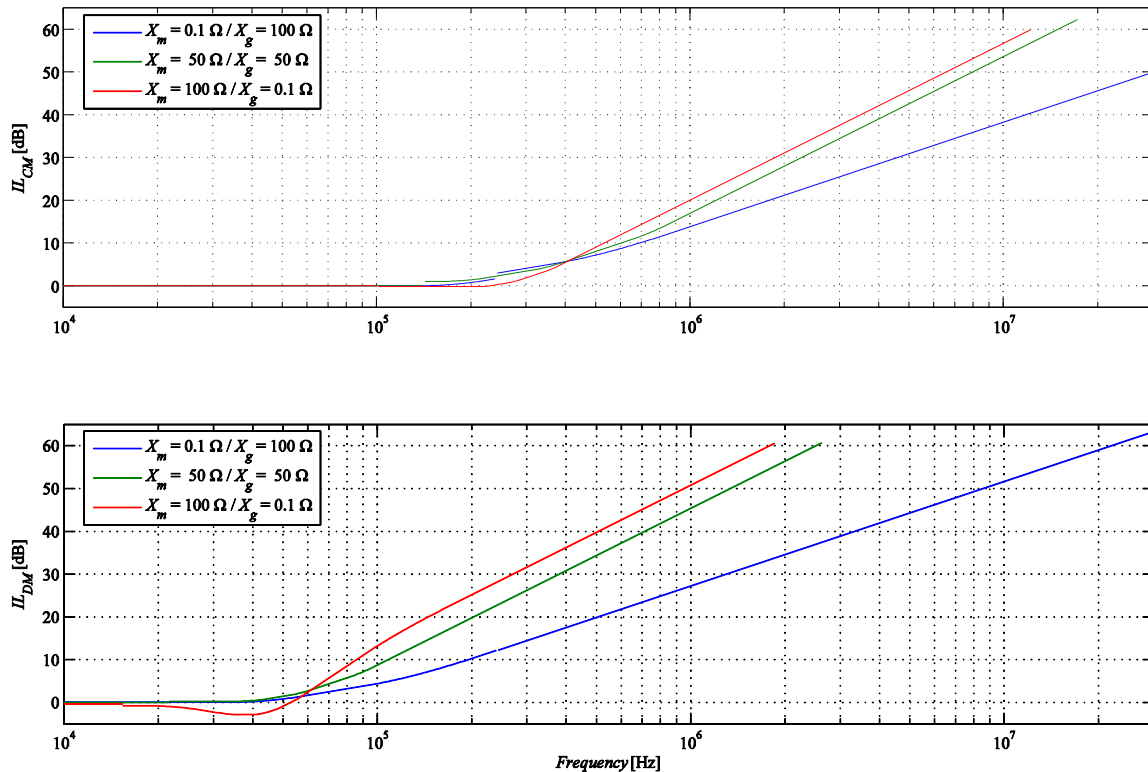


Fig. 8. CM and DM *IL* characteristics for the filter in Problems 3 and 4.

Note that in compliance tests, thanks to the LISN, the DM load impedance is  $Z_m = 100 \Omega$  (two  $50 \Omega$  resistors in series). As in the CM case the noise source impedance  $Z_{DM}$  (Fig. 5b) is largely unknown and the same considerations apply

### Solution 5:

The required insertion loss is 50 dB at 150 kHz.

- 1) Determine the cut-off frequency ( $f_c$ ) from Fig. 9.3 in the textbook:

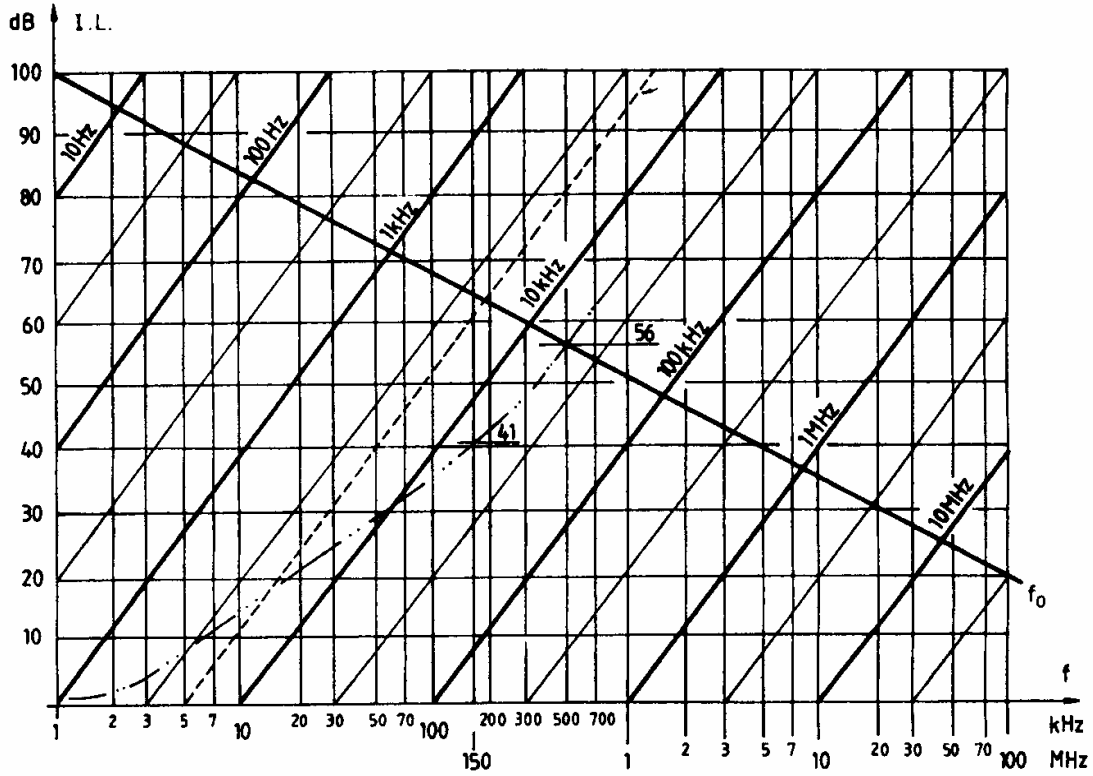


Fig. 9. Figure 9.3 from the textbook. Butterworth response, i.e. the  $IL$  for ideally damped LC-configuration with resistive source and load impedances.

Find the intersection point of  $f = 150$  kHz and  $IL = 50$  dB. Draw a 40 dB/decade line through that point. The intersection with  $x$ -axis gives the required  $f_0$ , which in this case is  $f_0 \approx 8$  kHz.

2) Determine the maximum inductance  $L_{\max}$  from the allowed voltage drop at maximum rms current: In this example  $V_{L_{\max}} = 5$  V at  $I_{L_{\max}} = 15$  A, at line frequency 50 Hz. Therefore,

$$V_{L_{\max}} = X_{L_{\max}} \cdot I_{L_{\max}} = \omega L_{\max} \cdot I_{L_{\max}} \Rightarrow L_{\max} = \frac{V_{L_{\max}}}{\omega \cdot I_{L_{\max}}} = \frac{5}{2\pi \cdot 50 \cdot 15} = 1.06 \text{ mH} \quad (1.17)$$

3) Determine capacitor  $C$ :

$$\omega_0^2 = \frac{1}{LC} \Rightarrow C = \frac{1}{(2\pi f_0)^2 L} = \frac{1}{(2\pi \cdot 8 \cdot 10^3)^2 \cdot 1.06 \cdot 10^{-3}} \approx 3.73 \cdot 10^{-7} \text{ F} = 373 \text{ nF} \quad (1.18)$$

Select  $C = 390$  nF and calculate the inductance  $L$ :

$$\omega_0^2 = \frac{1}{LC} \Rightarrow L = \frac{1}{(2\pi f_0)^2 C} = \frac{1}{(2\pi \cdot 8 \cdot 10^3)^2 \cdot 390 \cdot 10^{-9}} \approx 1.01 \cdot 10^{-3} \text{ H} = 1.01 \text{ mH} < L_{\max} \quad (1.19)$$

4) The damping ratio according (9.3) in the textbook is:

$$d = \frac{L}{CR^2} \approx 104.09 \quad (1.20)$$

From Fig. 10, with  $a = \lg d \approx 2.017$  and normalized frequency  $F = \frac{f}{f_0} = \frac{150}{8} = 18.75$ , the  $IL \approx 50$  dB.



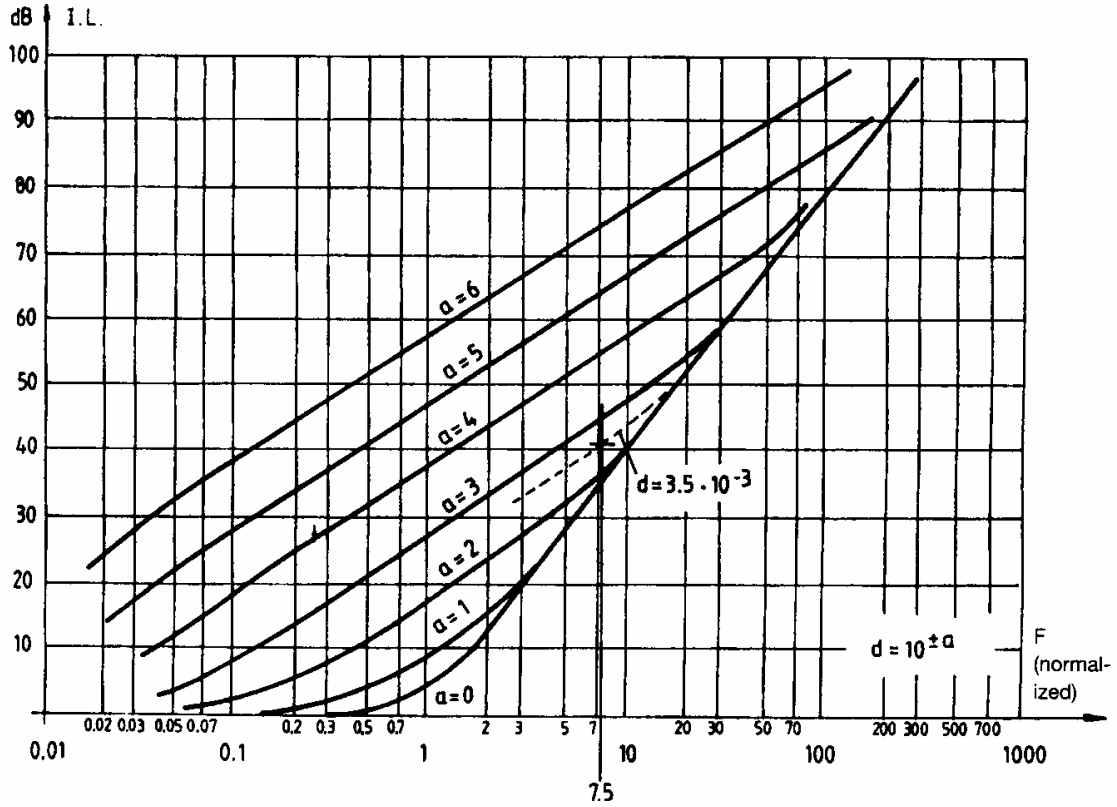


Fig. 10. Figure 9.4 from the textbook.  $IL$  chart for non-ideally damped LC-configuration with resistive source and load impedances.

An alternative way is to find  $D$  from (9.4):

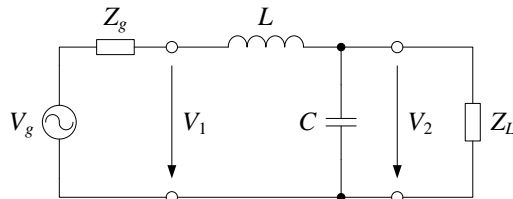
$$D = \frac{1-d}{\sqrt{d}} \approx -10.1 \quad (1.21)$$

Then from (9.1), the  $IL$  is:

$$IL = 10 \cdot \lg \left( 1 + F^2 \frac{D^2}{2} + F^4 \right) \approx 51.51 \text{ dB} \quad (1.22)$$

Note that the procedure described in this solution applies for filters terminated by equal and resistive source and load impedances. In any other case the  $IL$  will differ.

### Solution 6:



$$\frac{V_2}{V_1} = \frac{\frac{Z_L X_C}{Z_L + X_C}}{X_L + \frac{Z_L X_C}{Z_L + X_C}} = \frac{\frac{j\omega L_L / j\omega C}{j\omega L_L + 1/j\omega C}}{j\omega L + \frac{j\omega L_L / j\omega C}{j\omega L_L + 1/j\omega C}} = \frac{L_L}{L + L_L - \omega^2 L_L LC} \quad (1.23)$$

The worst case  $IL$  is when the filter and the load resonate. The resonance occurs at frequencies, at which the denominator in (1.23) is zero. The resonance would be at 150 kHz if  $L_L$  is:

$$L + L_L - \omega^2 L_L LC = 0 \Rightarrow L_L = \frac{L}{\omega^2 LC - 1} \approx 4.5 \cdot 10^{-6} \text{ H} = 4.5 \text{ } \mu\text{H} \quad (1.24)$$

To derive the  $IL$  in the case when  $Z_L = R = 50 \text{ } \Omega$  resistance one need the powers dissipated over  $R$  with and without filter:

$$\left. \begin{array}{l} P_1 = \frac{V_1^2}{R} \\ P_2 = \frac{V_2^2}{R} \end{array} \right\} \Rightarrow IL = 10 \cdot \lg \left( \frac{P_1}{P_2} \right) = 20 \cdot \lg \left| \frac{V_1}{V_2} \right| \quad (1.25)$$

When the  $Z_L$  in (1.23) is replaced by  $R$  the result is:

$$\frac{V_2}{V_1} = \frac{\frac{RX_C}{R + X_C}}{X_L + \frac{RX_C}{R + X_C}} = \frac{R}{R - \omega^2 LRC + j\omega L} \quad (1.26)$$

Then the  $IL$  in (1.25) becomes:

$$IL = 20 \cdot \lg \left| \frac{R - \omega^2 LRC + j\omega L}{R} \right| = 20 \cdot \lg \sqrt{(1 - \omega^2 LC)^2 + \left( \frac{\omega L}{R} \right)^2} \quad (1.27)$$

Equation (1.27) is the expression for  $IL$  of an LC-filter with resistive load. With the values in this Problem at 150 kHz the  $IL$  is about 46.92 dB.